

Notice of References Cited	Application/Control No. 10/633,522	Applicant(s)/Patent Under Reexamination SHIGENO ET AL.	
	Examiner Shih-wen Hsieh	Art Unit 2861	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,203,136	03-2001	Takahashi et al.	347/32
	B	US-6,010,203	01-2000	Muraki, Motohito	347/30
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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